

ISSUED BY Shenzhen BALUN Technology Co., Ltd.

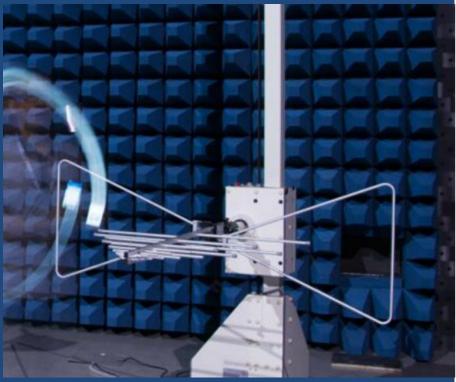


FOR

Hand Hygiene Sensor

ISSUED TO CENTRAK, INC.

826 Newtown Yardley Road, Newtown, Pennsylvania 18940, United States



Tested by:

Xiong Chong Xiong Chong

Date Mar. 10, 2022

Approved by:

Liao Jianming

(Technical Director)

Mar. 10, 2022 Date

Report No.:

BL-SZ21B1060-402 **EUT Name: Hand Hygiene Sensor**

Model Name: IT-376 (refer section 2.4)

Brand Name: Centrak

Test Standard: 47 CFR Part 15 Subpart C

> RSS-310 Issue 5 RSS-Gen Issue 5

(refer section 3.1)

FCC ID: ST2-IT376B

Test Conclusion: **Pass**

> Test Date: Dec. 06, 2021

Date of Issue: Mar. 10, 2022

NOTE: This test report of test results only related to testing samples, which can be duplicated completely for the legal use with the approval of the applicant; it shall not be reproduced except in full, without the written approval of Shenzhen BALUN Technology Co., Ltd. Any objections should be raised within thirty days from the date of issue. To validate the report, please contact us.

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Revision History

VersionIssue DateRevisionsRev. 01Feb. 28, 2022Initial Issue

Rev. 02 Mar. 10, 2022 Modify the name and address of the

applicant

Update Product Type in section 2.6

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1 GENERAL INFORMATION

1.1 Identification of the Testing Laboratory

Company Name	Shenzhen BALUN Technology Co., Ltd.
Address	Block B, 1st FL, Baisha Science and Technology Park, Shahe Xi
	Road, Nanshan District, Shenzhen, Guangdong Province, P. R. China
Phone Number	+86 755 6685 0100

1.2 Identification of the Responsible Testing Location

Test Location	Shenzhen BALUN Technology Co., Ltd.
A dalua a a	Block B, 1st FL, Baisha Science and Technology Park, Shahe Xi
Address	Road, Nanshan District, Shenzhen, Guangdong Province, P. R. China
	All measurement facilities used to collect the measurement data are
Description	located at Block B, FL 1, Baisha Science and Technology Park, Shahe
Description	Xi Road, Nanshan District, Shenzhen, Guangdong Province, P. R.
	China 518055

1.3 Laboratory Condition

Ambient Temperature	20°C to 25°C
Ambient Relative Humidity	30% to 60%
Ambient Pressure	100 kPa to 102 kPa

1.4 Announce

- (1) The test report reference to the report template version v1.2.
- (2) The test report is invalid if not marked with the signatures of the persons responsible for preparing and approving the test report.
- (3) The test report is invalid if there is any evidence and/or falsification.
- (4) The results documented in this report apply only to the tested sample, under the conditions and modes of operation as described herein.
- (5) This document may not be altered or revised in any way unless done so by BALUN and all revisions are duly noted in the revisions section.
- (6) Content of the test report, in part or in full, cannot be used for publicity and/or promotional purposes without prior written approval from the laboratory.
- (7) The laboratory is only responsible for the data released by the laboratory, except for the part provided by the applicant.



2 PRODUCT INFORMATION

2.1 Applicant Information

Applicant	CENTRAK, INC.
A -l -l	826 Newtown Yardley Road, Newtown, Pennsylvania 18940,
Address	United States

2.2 Manufacturer Information

Manufacturer	CENTRAK, INC.
A ddraga	826 Newtown Yardley Road, Newtown, Pennsylvania 18940,
Address	United States

2.3 Factory Information

Factory	Concord Electronic (Huizhou) Ltd.
Addross	21, Ping An Rd, Shuikou Street, Hui Cheng District, Huizhou City,
Address	Guangdong Province, China

2.4 General Description for Equipment under Test (EUT)

EUT Name	Hand Hygiene Sensor
Model Name Under Test	IT-376
Series Model Name	IT-376 H
Description of Model	All models are same with electrical parameters and internal circuit
name differentiation	structure, but only differ in model name.
Hardware Version	V[A]
Software Version	V3.0
Dimensions (Approx.)	N/A
Weight (Approx.)	N/A

2.5 Ancillary Equipment

Note: Not applicable.

2.6 Technical Information

Network and Wireless	RFID, 125kHz (Only TX)
connectivity	KI ID, 125KI IZ (OIIIY 17/)

The requirement for the following technical information of the EUT was tested in this report:

5	· · · · · · · · · · · · · · · · · · ·	
Modulation Type	ASK	
Product Type	☐ Portable	
	☐ Fix Location	
Frequency Range	125kHz	
Receiver Categorization	N/A	
Number of channel	1	
Tested Channel	1	
Antenna Type	Coil Antenna	



3 SUMMARY OF TEST RESULTS

3.1 Test Standards

No.	Identity	Document Title
	47 CFR Part 15,	
1	Subpart C	Intentional Radiators
	(10-1-19 Edition)	
	ANCI C62 40 2042	American National Standard for Testing Unlicensed Wireless
2	ANSI C63.10-2013	Devices
3	RSS-Gen Issue 5	General Requirements for Compliance of Radio Apparatus
4	RSS-310 Issue 5	Licence-Exempt Radio Apparatus: Category II Equipment

3.2 Verdict

No.	Description	FCC Part No.	ISED Part No.	Test Result	Verdict	
1	Dadiated Emission	15.209,15.215	RSS-310 10.6	Annex A.1	Door	
	Radiated Emission	(b)	RSS-Gen 8.9	Allilex A. I	Pass	
2	Conducted Emission, AC	15.207	RSS-Gen 8.8	Annex A.2	N/A	
	Ports	15.207	N33-Gen 6.6	Alliex A.2	IN/A	
3	Emissions Bandwidth	N/A	RSS-Gen 6.7	Annex A.3	Pass	

3.3 Test Uncertainty

The following measurement uncertainty levels have been estimated for tests performed on the EUT as specified in CISPR 16-4-2. This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

Measurement	Value
Conducted emissions (9 kHz-30 MHz)	2.96 dB
Radiated emissions (30 MHz-1 GHz)	3.67 dB
Radiated emissions (1 GHz-18 GHz)	3.57 dB



4 GENERAL TEST CONFIGURATIONS

4.1 Test Environments

Relative Humidity	30% to 60%		
Atmospheric Pressure	100 kPa to 102 kPa		
Temperature	NT (Normal Temperature)	25°C	
Working Voltage of the EUT	NV (Normal Voltage)	3.3V	

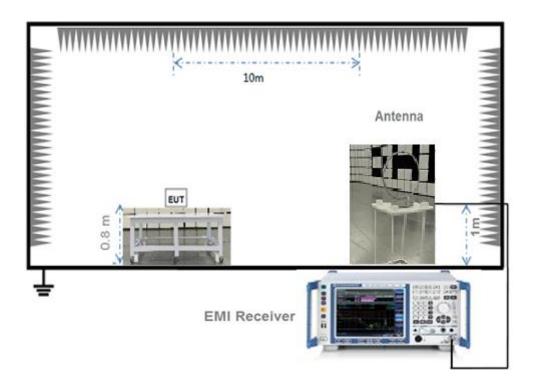
4.2 Test Equipment List

Description	Manufacturer	Model Serial No.		Cal. Date	Cal. Due	
EMI Receiver	ROHDE&SCHWARZ	ESRP	101036	2021.10.10	2022.10.09	
Test Antenna-						
Loop(9 kHz-30	SCHWARZBECK	FMZB 1519	1519-037	2021.04.16	2024.04.15	
MHz)						
Test Antenna-						
Bi-Log(30 MHz-	SCHWARZBECK	VULB 9163	9163-624	2021.08.20	2024.08.19	
3 GHz)						
Anechoic	EMC Electronic Co.,	20.10*11.60*7	N/A	2021.08.15	2024.08.14	
Chamber	Ltd	.35m	IN/A	2021.00.13	2024.00.14	
EMI Receiver	KEYSIGHT	N9010B	MY5711030	2021.10.10	2022.10.09	
Elvii Receivei	KETSIGHT	1490100	9	2021.10.10	2022.10.09	
LISN	SCHWARZBECK	NSLK 8127	8127-687	2021.06.08	2022.06.07	
Shielded	YiHeng Electronic	3.5m*3.1m*2.	N/A	2019.08.16	2022.08.15	
Enclosure	Co., Ltd	8m	IN/A	2019.00.10	2022.00.15	
Test Software	BALUN	BL410_E	V19.918			



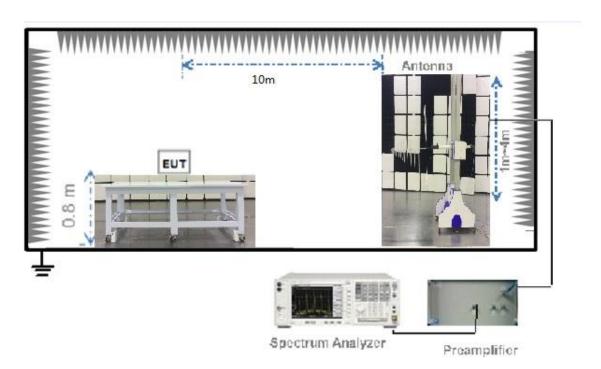
4.3 Test Setups

Test Setup 1



For Radiated Emission Test (Below 30 MHz))

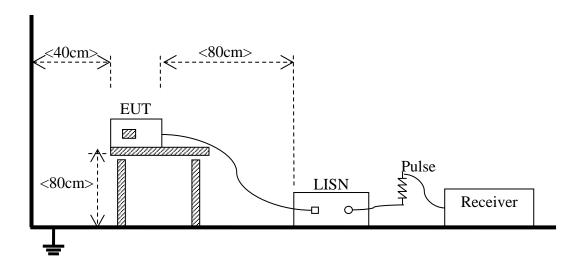
Test Setup 2



(For Radiated Emission Test (30 MHz-1 GHz))



Test Setup 3



(For Conducted Emission, AC Ports Test)



5 TEST ITEMS

5.1 Emission Tests

5.1.1 Radiated Emission

5.1.1.1 Limit

Frequency (MHz)	Field Strength (μV/m)	Measurement Distance (m)
0.009 - 0.490	2400/F(kHz)	300
0.490 - 1.705	24000/F(kHz)	30
1.705 - 30.0	30	30
30 - 88	100	3
88 - 216	150	3
216 - 960	200	3
Above 960	500	3

NOTE:

- 1) Field Strength ($dB\mu V/m$) = 20*log [Field Strength ($\mu V/m$)].
- 2) In the emission tables above, the tighter limit applies at the band edges.
- 3) For above 1000 MHz, limit field strength of harmonics: 54 dBuV/m@3 m (AV) and 74 dBuV/m@3 m (PK)
- 4) At frequencies below 30 MHz, measurements may be performed at a distance closer than that specified in the regulations, when performing measurements at a closer distance than specified, the results shall be extrapolated to the specified distance by either making measurements at a minimum of two distances on at least one radial to determine the proper extrapolation factor or by using the square of an inverse linear distance extrapolation factor (40 dB/decade). For example, at the frequency 9 kHz, limit @10m = 20*log (2400/f) + 40log (dlimit/dmeasure) where limit = 300m, dmeasure=10m. limit @10m = 20*log (2400/9) + 40log (300/10) = 107.5 (dBµV/m).
- 5) At frequencies at or above 30 MHz, measurements may be performed at a distance other than what is specified provided, When performing measurements at a distance other than that specified, the results shall be extrapolated to the specified distance using an extrapolation factor of 20 dB/decade (inverse linear-distance for field strength measurements; inverse-linear-distance-squared for power density measurements). For example, at the frequency 30 MHz, limit @10m = $20*\log (100) + 20\log (dlimit/dmeasure)$ where limit = 3m, dmeasure=10m. limit @10m = $20*\log (3/10) = 29.5 (dB\mu V/m)$.

5.1.1.2 Test Setup

Refer to 4.3 section (test setup 1 to test setup 2) for radiated emission test, the photo of test setup please refer to ANNEX B.

5.1.1.3 Test Procedure

All Spurious Emission tests were performed in X, Y, Z axis direction. And only the worst axis test condition was recorded in this test report.

An initial pre-scan was performed in the chamber using the EMI Receiver in peak detection mode. Quasi-peak measurements were conducted based on the peak sweep graph. The EUT was measured by Bi-Log antenna with 2 orthogonal polarities.

5.1.1.4 Test Result

Please refer to ANNEX A.1.



NOTE:

1. Results (dBuV/m) = Reading (dBuV/m) + Factor (dB/m)

The reading level is calculated by software which is not shown in the sheet

- 2. Factor (dB/m) = Antenna Factor (dB/m) + Cable Factor (dB) Amplifier Gain (dB)
- 3. Over limit = Results Limit.



5.1.2 Conducted Emission

5.1.2.1 Test Limit

Frequency range	Conducted Limit (dBµV)				
(MHz)	Quasi-peak	Average			
0.15 - 0.50	66 to 56	56 to 46			
0.50 - 5	56	46			
5 - 30	60	50			

NOTE:

- 1) The limit is applicable to Class B ITE.
- 2) The lower limit shall apply at the band edges.
- 3) The limit decreases linearly with the logarithm of the frequency in the range 0.15 0.50 MHz.

5.1.2.2 Test Setup

Refer to 4.3 section test (test setup 3) for conducted emission, the photo of test setup please refer to ANNEX B.

5.1.2.3 Test Procedure

The EUT is connected to the power mains through a LISN which provides $50 \Omega/50 \mu H$ of coupling impedance for the measuring instrument. The test frequency range is from 150 kHz to 30 MHz. The maximum conducted interference is searched using Peak (PK), Quasi-peak (QP) and Average (AV) detectors; the emission levels that are more than the AV and QP limits, and that have narrow margins from the AV and QP limits will be re-measured with AV and QP detectors. Tests for both L phase and N phase lines of the power mains connected to the EUT are performed.

Devices subject to Part 15 must be tested for all available U.S. voltages and frequencies (such as a nominal 120 VAC, 50/60 Hz and 240 VAC, 50/60 Hz) for which the device is capable of operation. A device rated for 50/60 Hz operation need not be tested at both frequencies provided the radiated and line conducted emissions are the same at both frequencies.

5.1.2.4 Test Result

Please refer to ANNEX A.2.

NOTE:

1. Results (dBuV) = Reading (dBuV) + Factor (dB)

The reading level is calculated by software which is not shown in the sheet

- 2. Factor = Insertion loss + Cable loss
- 3. Over limit = Results Limit.



5.1.3 Emission bandwidth

5.1.3.1 Limit

FCC §15.215(c)

The 20 dB bandwidth is known as the 99% emission bandwidth, or 20 dB bandwidth (10*log1%=20 dB) taking the total RF output power.

5.1.3.2 Test Setup

Refer to 4.3 section test (test setup 1) for test setup description for the antenna port. The photo of test setup please refer to ANNEX B.

5.1.3.3 Test Procedure

Use the following spectrum analyzer settings:

Span = between 2 to 5 times the OBW

RBW = 1% to 5% the OBW

VBW ≥ 3RBW

Sweep = auto

Detector function = peak

Trace = max hold

The 99% emission bandwidth is measured with a spectrum analyzer connected via a receiver antenna placed near the EUT while the EUT is operating in transmission mode.

Use the following spectrum analyzer settings:

Span = between 1.5 to 5 times the OBW

RBW = 1% to 5% OBW

VBW ≥ 3RBW

Sweep = auto

Detector function = peak

Trace = max hold

The EUT should be transmitting at its maximum data rate, Allow the trace to stabilize.

5.1.3.4 Test Result

Please refer to ANNEX A.3.



ANNEX A TEST RESULTS

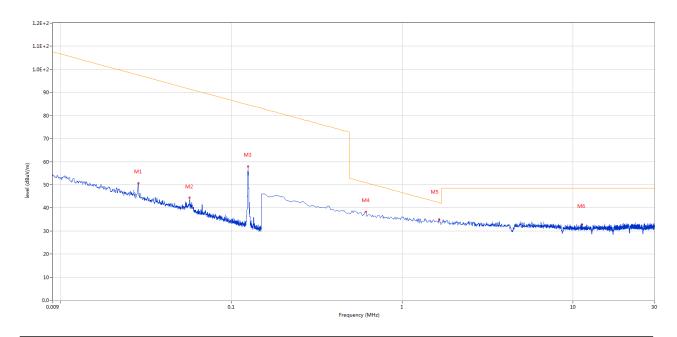
A.1 Radiated Emission

Note ¹: The symbol of "--" in the table which means not application.

Note ²: For the test data above 1 GHz, according the ANSI C63.4-2014, where limits are specified for both average and peak (or quasi-peak) detector functions, if the peak (or quasi-peak) measured value complies with the average limit, it is unnecessary to perform an average measurement.

Test Data and Plots

A.1.1 Test Antenna Vertical, 9 kHz -30 MHz



No.	Frequency	Results	Factor	Limit	Over Limit	Detector	Table	Height	Antenna	Verdict
	(MHz)	(dBuV/m)	(dB)	(dBuV/m)	(dB)		(Degree)	(cm)		
1	0.029	50.64	20.15	97.5	-46.86	Peak	318.00	100	Vertical	Pass
2	0.057	44.35	20.20	91.5	-47.15	Peak	1.00	100	Vertical	Pass
3	0.125	57.92	20.15	84.6	-26.68	Peak	292.00	100	Vertical	N/A
4	0.613	38.24	20.34	50.9	-12.66	Peak	236.00	100	Vertical	Pass
5	1.650	35.08	20.46	42.3	-7.22	Peak	360.00	100	Vertical	Pass
6	11.314	32.89	20.83	48.5	-15.61	Peak	200.00	100	Vertical	Pass

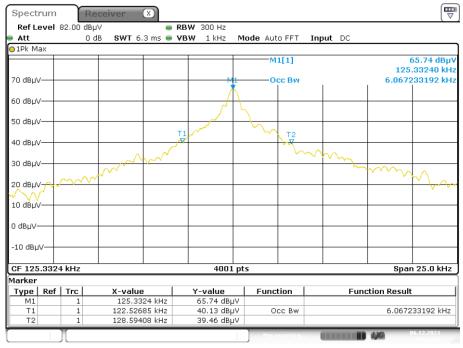


A.2 Conducted Emission

Note: Not applicable.

A.3 Emissions Bandwidth

Test Data and Plots



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ANNEX B TEST SETUP PHOTOS

Please refer the document "BL-SZ21B1060-AE-2.PDF".

ANNEX C EUT EXTERNAL PHOTOS

Please refer the document "BL-SZ21B1060-AW.PDF".

ANNEX D EUT INTERNAL PHOTOS

Please refer the document "BL-SZ21B1060-AI.PDF".

--END OF REPORT--